Search Notes



Application/Control	No.

Applicant(s)/Patent under Reexamination

LEE ET AL.

10/643,898 Examiner

Art Unit

McDieunel Marc

3661

SEARCHED				
Class	Subclass	Date	Examiner	
700	245 246 247 249 250 252 253 254 258 260	7/17/2005	ММ	
901	1 2 9	7/17/2005	MM ·	
701	23	7/17/2005	ММ	
180	8.1 8.6	7/17/2005	ММ	
318	568.1	7/17/2005	ММ	
318	568.11	7/17/2005	ММ	
318	568.12	7/17/2005	ММ	
318	568.15	7/17/2005	ММ	
318	568.16	7/17/2005	ММ	
318	568.17	7/17/2005	ММ	
318	568.22	7/17/2005	ММ	
318	568.25	7/17/2005	ММ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	SIRAILGY	
	DATE	EXMR
Palm inventors search	7/17/2005	ММ
West search see attached listings	7/17/2005	MM
PLUS search	7/17/2005	
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